

Application/Control No.	Applicant(s)/Patent under Reexamination
10/014,095	OHNISHI, OSAMU
Examiner	Art Unit

2637

Rokeya Everett

SEARCHED					
Class	Subclass	Date	Examiner		
375	150	9/29/2005	RE		
375	142	9/29/2005	RE		
375	350	9/29/2005	RE		
370	342	9/29/2005	RE		
375	343	9/29/2005	RE		
375	200	9/29/2005	RE		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
-					
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (prior art, inventor search)	9/29/2005	RE		
Discussion with Jay Patel (class 375)	9/29/2005	RE		
Palm (inventor search, NPL search)	9/28/2005	RE		
IEEE Explorer(masking correlation)	9/30/2005	RE		